

**P-Channel MOSFET** 

## **General Description**

The WSP30P15 is the highest performance Trench P-Channel MOSFET with extreme high cell density, which provide excellent  $R_{DS(ON)}$  and gate charge for most of the synchronous buck converter applications.

The WSP30P15 meet the RoHS and Green Product requirement, 100%  $E_{AS}$  guaranteed with full function reliability approved.

#### **Features**

- 100% UIS Tested.
- Reliable and Rugged
- Lead Free and Green Devices Available (RoHS Compliant)

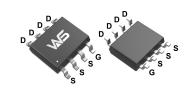
## **Product Summery**

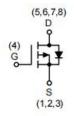
BV <sub>DSS</sub>	R <sub>DS(ON)</sub>	I <sub>D</sub>
-30V	8.5mΩ	-15A

## **Applications**

- Power Management for Industrial DC/DC Converters
- Uninterruptible power supply

# **SOP-8L Pin Configuration**





# **Absolute Maximum Ratings** (T<sub>A</sub>=25°C, Unless Otherwise Noted)

Symbol	Parameter		Rating	Units	
V <sub>DS</sub>	Drain-Source Voltage		-30	.,	
V <sub>GS</sub>	Gate-Source Voltage		±20	V	
. 7	Continuous Drain Current	T <sub>C</sub> =25°C	-15		
I <sub>D</sub> <sup>7</sup>	Continuous Drain Current	T <sub>C</sub> =100°C	-9.3	Α	
I <sub>DM</sub> <sup>3</sup>	Pulse Drain Current		-73		
P <sub>D</sub> <sup>2</sup>	Power Dissipation	T <sub>C</sub> =25°C	3.1	W	
I <sub>AS</sub> <sup>3</sup>	Single pulse Avalanche Current		-21	А	
E <sub>AS</sub> <sup>3</sup>	Single pulse Avalanche Energy	L=0.3mH	132	mJ	
T <sub>STG</sub>	Storage Temperature Range		-55 to 150	°C	
T <sub>J</sub>	Operating Junction Temperature Range		-55 to 150	°C	
D 14	Thermal Decistors of Lunction to Archivet	t≤10s	31		
R <sub>0JA</sub> 1,4	Thermal Resistance-Junction to Ambient	Steady State	59	°C/W	
R <sub>θJC</sub>	R <sub>θJC</sub> Thermal Resistance-Junction to Case		16	1	



### Electrical Characteristics (T<sub>J</sub>=25°C, Unless Otherwise Noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Units
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V , I <sub>D</sub> =-250μA	-30			V
P	Static Drain-Source On-Resistance	V <sub>GS</sub> =-10V , I <sub>D</sub> =-5A		8.5	12	mΩ
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance	V <sub>GS</sub> =-4.5V , I <sub>D</sub> =-5A		12.5	15	11122
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS}$ = $V_{DS}$ , $I_{D}$ =-250 $\mu$ A	-1.0	-1.6	-2.2	V
	Drain Source Leakage Current	$V_{DS}$ =-30V , $V_{GS}$ =0V			-1.0	
I <sub>DSS</sub>	Drain-Source Leakage Current	T <sub>J</sub> =55°C			-5.0	0 μΑ
I <sub>GSS</sub>	Gate-Source Leakage Current	V <sub>DS</sub> =0V , V <sub>GS</sub> =±20V			±100	nA
9 <sub>fs</sub>	Forward Transconductance	$V_{DS}$ =-5V , $I_{D}$ =-5A		30		S
$R_G$	Gate Resistance	f=1.0MHz		2.0		Ω
$Q_{g}$	Total Gate Charge (10V)			32		
$Q_{g}$	Total Gate Charge (4.5V)	V <sub>DS</sub> =-15V , V <sub>GS</sub> =-10V , I <sub>D</sub> =-20A		22		nC
$Q_gs$	Gate-Source Charge	V <sub>DS</sub> 13V , V <sub>GS</sub> 10V , I <sub>D</sub> 20A		6.8		lic
$Q_{gd}$	Gate-Drain Charge			8.1		
$T_{d(on)}$	Turn-On Delay Time			15		
T <sub>r</sub>	Rise Time	$V_{DS}$ =-15V , $V_{GS}$ =-10V , $I_{D}$ =-5A		21		no
$T_{d(off)}$	Turn-Off Delay Time	$R_{I}=1\Omega$ , $R_{GEN}=3\Omega$		55		ns
T <sub>f</sub>	Fall Time	] = , , , , , , , , , , , , , , , , , ,		48		
C <sub>iss</sub>	Input Capacitance			2511		
C <sub>oss</sub>	Output Capacitance	$V_{DS}$ =-30V , $V_{GS}$ =0V , $f$ =1.0MHz		243		pF
C <sub>rss</sub>	Reverse Transfer Capacitance			229		

#### **Diode Characteristics**

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Units
I <sub>S</sub> <sup>7</sup>	Continuous Source Current				-15	Α
V <sub>SD</sub>	Diode Forward Voltage	V <sub>GS</sub> =0V , I <sub>S</sub> =-1A		-0.7	-1.2	V
t <sub>rr</sub>	Reverse Recovery Time	I <sub>F</sub> =-20A , di/dt=500A/μs		32		ns
Q <sub>rr</sub>	Reverse Recovery Charge	η <sub>F</sub> =-20Α', αι/αι-300Α/μς		26		nC

#### Note:

- 1. The value of R<sub>BJA</sub> is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25°C. The Power dissipation P<sub>DSM</sub> is based on R<sub>BJA</sub> t≤ 10s and the maximum allowed junction temperature of 150°C. The value in any given application depends on the user's specific board design.
- 2. The power dissipation P<sub>D</sub> is based on T<sub>J(MAX)</sub>=150°C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.
- 3. Single pulse width limited by junction temperature  $T_{J(MAX)}$ =150°C.
- 4. The  $R_{\theta JA}$  is the sum of the thermal impedance from junction to case  $R_{\theta JC}$  and case to ambient.
- 5. The static characteristics in Figures 1 to 6 are obtained using  $<300\mu s$  pulses, duty cycle 0.5% max.
- 6. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of T<sub>J(MAX)</sub>=150°C. The SOA curve provides a single pulse rating.
- 7. The maximum current rating is package limited.
- 8. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub>=25°C.
- 9. The maximum current rating is silicon limited



## **Typical Characteristics**

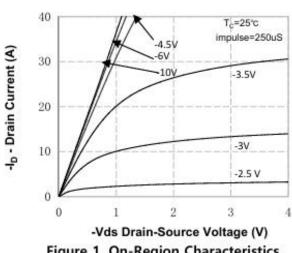
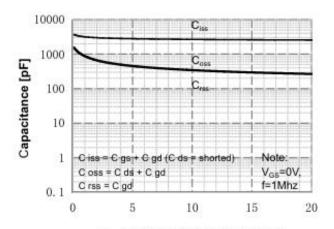


Figure 1. On-Region Characteristics Rdson On-Resistance(mΩ) Note: T\_=25°C 20  $V_{GS} = -4.5V$ 10 V<sub>gs</sub>= -10V 0 10 15 20 25 30 35 40 5

-ID - Drain Current (A)
Figure 3. On-Resistance Variation vs
Drain Current and Gate Voltage



-V<sub>DS</sub> Drain-to-Source Voltage (V) Figure 5. Capacitance Characteristics

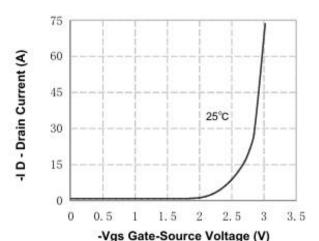
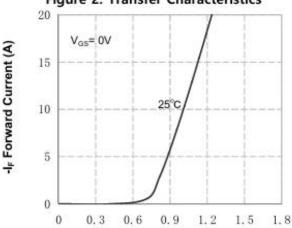
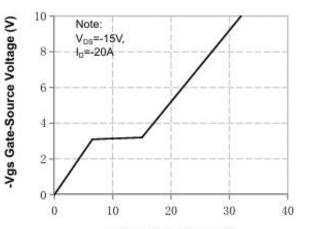


Figure 2. Transfer Characteristics



-VF ,Forward Voltage (V)
Figure 4. Body Diode Forward Voltage
Variation with Source Current
and Temperature



Qg Gate Charge (nC)
Figure 6. Gate Charge Characteristics



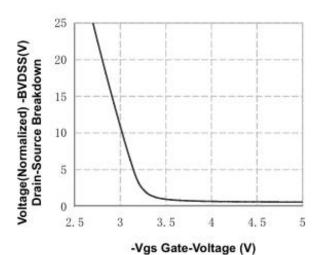


Figure 7. Breakdown Voltage Variation vs Gate-Voltage

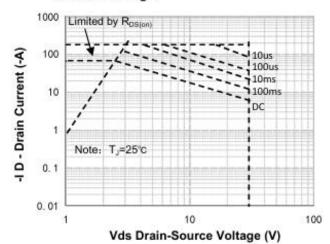
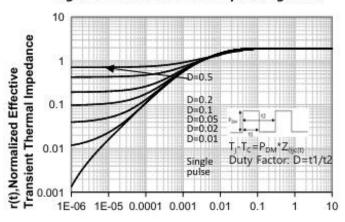


Figure 9. Maximum Safe Operating Area



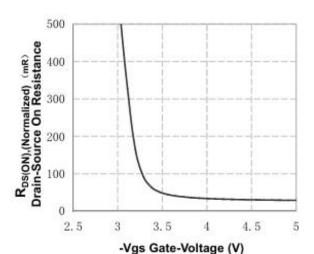


Figure 8. On-Resistance Variation vs Gate Voltage

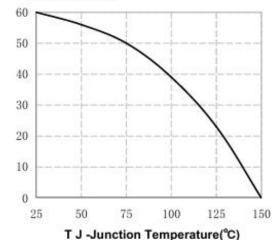


Figure 10. Maximum PContinuous Drain Currentvs Case Temperature

Square Wave Pluse Duration(sec)

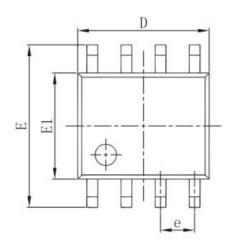
Figure 11. Transient Thermal Response Curve

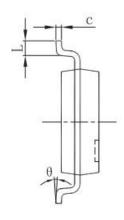
-lo - Drain Current (A)

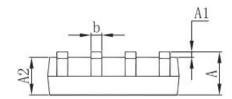




# **Packaging information**







Symbol	Dimensions In	Millimeters	Dimensions	In Inches
	Min	Max	Min	Max
A	1. 350	1. 750	0.053	0.069
A1	0. 100	0. 250	0.004	0.010
A2	1. 350	1. 550	0.053	0.061
b	0.330	0. 510	0.013	0.020
с	0. 170	0. 250	0.007	0.010
D	4.800	5. 000	0.189	0.197
e	1.270 (BSC)		0.050	(BSC)
Е	5. 800	6. 200	0. 228	0. 244
E1	3.800	4. 000	0.150	0.157
L	0.400	1. 270	0.016	0.050
θ	0°	8°	0°	8°





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